



U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE					ATTY. DOCKET NO. M122-1518	SERIAL NO. 09/653,156	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Vishnu K. Agarwal		
FILING DATE August 31, 2000					GROUP 2813		
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TN	AA	6,270,572	08/01	Kim et al	—	—	—
	AB						
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FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
	AM						Yes
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER <i>[Signature]</i>				DATE CONSIDERED <i>3/21/05</i>			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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Form PTO-1449  LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				ATTY. DOCKET NO. M122-1518		SERIAL NO. 09/653,156	
				APPLICANT Vibha K. Agarwal			
				FILING DATE August 31, 2000		GROUP 2B31	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
YJ	AA	6,281,142	06/1999	Basceri et al			
WV	AB	6,204,172	09/1998	Marsh			
YL	AC	5,432,732	07/1995	Obzni			
NY	AD	6,242,299	06/2001	Hickert			
NP	AE	6,249,056	06/2001	Kwon			
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		Document Number	Date	Country	Class	Subclass	Translation
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EXAMINER		DATE CONSIDERED 5/3/02					
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 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. MI22-1518	SERIAL NO. 09/653,156		
				APPLICANT Vishnu K. Agarwal			
				FILING DATE August 31, 2000	GROUP 283		
U.S. PATENT DOCUMENTS							
*Examiner's Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
AA		09/652,537		Derdarian (as amended 11/29/2001)			08/31/2000 KC 5/31/2002
AB				The document isn't available for review			
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Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
MI22-1518SERIAL NO.
09/653,156LIST OF ART CITED BY APPLICANT
(Use back sheets if necessary)

APPLICANT Vishnu K. Agarwal

FILING DATE
August 31, 2000GROUP
2813

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U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
U	AA 6,335,240	01-2002	Kim et al			
W	AB 5,156,606	12-2000	Michaelis			
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FOREIGN PATENT DOCUMENTS

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				ATTY. DOCKET NO. M122-1318	SERIAL NO. 09/653,156	
				APPLICANT Vishnu K. Agarwal		
				FILING DATE August 31, 2000	GROUP 280	
U.S. PATENT DOCUMENTS						
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
Y	6,180,481	01/2001	DeBoer et al	—	—	—
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FOREIGN PATENT DOCUMENTS						
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EXAMINER			DATE CONSIDERED			
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				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
CG	AA	2002/0064915AI	05/2002	Kitamura			
Off	AB	2001/0023110AI	09/2001	Fukuzumi et al			
	AC						
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FOREIGN PATENT DOCUMENTS							
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EXAMINER		DATE CONSIDERED 4/27/03					

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<p style="text-align: center;">U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</p> <p>MAILED 1 JUN 2002 JC24</p> <p>ART CITED BY APPLICANT (Use several sheets if necessary)</p>				ATTY. DOCKET NO. MI22-1518		SERIAL NO. 09/653,156		
				APPLICANT Vishnu K. Agarwal				
				FILING DATE August 31, 2000		GROUP 2831		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA		5,641,984	06/1997	Aftergut et al	—	—	—	
AB		6,216,260	04/2001	Lea et al	—	—	—	
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FOREIGN PATENT DOCUMENTS								
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AO								
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EXAMINER		DATE CONSIDERED						
<p><i>[Signature]</i></p> <p>5/3/02</p>								
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